

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10539211	WANG ET AL.
	Examiner	Art Unit
	Hevey, John A	1709

SEARCHED			
Class	Subclass	Date	Examiner
252	62	7/19/07, 11/29/07	JAH
524	413	7/19/07, 11/29/07	JAH
423	594.9	11/29/07	JAH

SEARCH NOTES			
Search Notes	Date	Examiner	
East - see search history	7/19/07, 11/29/07	JAH	
Inventor search in PALM	7/19/07, 11/29/07	JAH	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner